INFORMATION DISCLOSURE CITATION

Docket: 015559-238

Serial. No.:

09/833,174

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Applicant:

James W. Siekkinen et al.

Filed: 4/11/01

Group: 2816

U.S. PATENT DOCUMENTS

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Examiner	Document No.	Date	Name	Class	Sub
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Examiner	Document No.	Date _	Country	Class	Sub	Y	N
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

RB	Miller, R.A., et al., Electromagnetic MEMS Scanning Mirrors, Electrical Engineering, MS136-93, California Institute of Technology (no date). Admitted to be prior art for the limited purpose of examination of this application; applicants reserve the right to challenge the status of this paper as prior art.				
RB	Miller, R.A., et al., Magnetically Actuated Micromirrors for Use as Optical Deflectors, Electrical Engineering, MS116-81, California Institute of Technology (no date). Admitted to be prior art for the limited purpose of examination of this application; applicants reserve the right to challenge the status of this paper as prior art.				
RB	Comtois, J.H., et al., Characterization of Electrothermal Actuators and Arrays Fabricated in a Four-Level, Planarized Surface-Micromachined Polycrystalline Silicon Process, Transducers '97, 1997 International Conference on Solid-State Sensors and Actuators (6/97).				
RB	Hosaka, H., et al., Electromagnetic Microrelays: Concepts and Fundamental Characteristics, 1993 IEEE (2/93).				
RB	Hyman, D., et al., Contact Physics of Gold Microcontacts for MEMS Switches, IEEE Transactions on Components and Packaging Technology, Vol. 22, No. 3. (9/99).				
RB	Majumder, S., et al., Electrostatically Actuated Micromechanical Switches, J. Vac. Sci. Technol. A 15(3) (5/97).				
RB	Statement (including Attachments A-D).				
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